

Notice of References Cited

Application/Control No.

10/673,282

Applicant(s)/Patent Under
Reexamination
YUN ET AL.

Examiner

Alexander S. Beck

Art Unit

2629

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,630,796	10-2003	Tokunaga et al.	315/169.4
*	B	US-6,756,977	06-2004	Ide, Shigeo	345/212
*	C	US-6,768,479	07-2004	Nakamura, Hideto	345/60
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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